

**N-Channel MOSFET** 

# **General Description**

The WSK170N04 is the highest performance SGT N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSK170N04 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS + R<sub>g</sub> Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

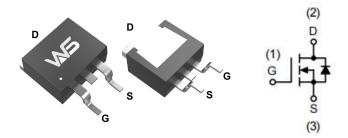
# **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	l <sub>D</sub>
40V	1.6mΩ	170A

## **Applications**

- Power Management for Industrial DC/DC Converters
- Load switch
- Battery protection

## **TO-263-2L Pin Configuration**



# **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
V <sub>DS</sub>	Drain-Source Voltage		40 V	
V <sub>GS</sub>	Gate-Source Voltage	Voltage		
1 7	Continuous Drain Current	T <sub>C</sub> =25°C	170	
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =100°C	110	Α
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		410	
P <sub>D</sub> <sup>2</sup>	Power Dissipation	T <sub>C</sub> =25°C	170	W
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		46	А
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy	L=0.3mH	410	mJ
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	- °C
TJ	Operating Junction Temperature Range		-55 to 150	
D 14	Thermal Desistance Junction to Ambient	t≤10s	20	
R <sub>θJA</sub> <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	Steady State	50	°C/W
R <sub>θJC</sub>	Thermal Resistance-Junction to Case		0.7	

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## Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	40			V	
В	Statia Duain Sayuna On Basistana	V <sub>GS</sub> =10V , I <sub>D</sub> =20A		1.6	2.2	0	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =20A		2.3	3.5	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_{D}$ =250 $\mu$ A	1.0	1.6	2.2	V	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =40V , V <sub>GS</sub> =0V			1.0	μA	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>DS</sub> =0V , V <sub>GS</sub> =±20V			±100	nA	
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =5V , $I_{D}$ =20A		53		S	
$R_G$	Gate Resistance	f=1.0MHz		1.0		Ω	
$Q_g$	Total Gate Charge (10V)			46			
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =20V , $V_{GS}$ =10V , $I_{D}$ =20A		11		nC	
$Q_{gd}$	Gate-Drain Charge			19			
$T_{d(on)}$	Turn-On Delay Time			19			
T <sub>r</sub>	Rise Time	$V_{DS}$ =20V , $V_{GS}$ =10V ,		9		no	
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_{I} = 1\Omega$ , $R_{GEN} = 3\Omega$		60		ns	
T <sub>f</sub>	Fall Time	52.1		30			
C <sub>iss</sub>	Input Capacitance			3950			
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =20V , $V_{GS}$ =0V , $f$ =1.0MHz		1150		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			83			

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				170	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A		0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	1 -204 di/dt-5004/ug		5		ns
Q <sub>rr</sub>	Reverse Recovery Charge	l <sub>F</sub> =20A , di/dt=500A/μs		12		nC

#### Note:

- The value of R<sub>θJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited



# **Typical Characteristics**

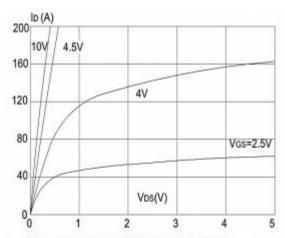


Figure1: Output Characteristics

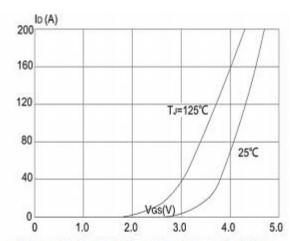
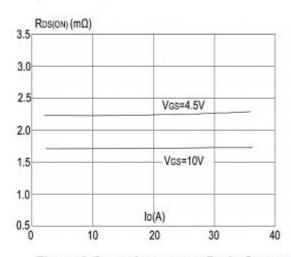


Figure 2: Typical Transfer Characteristics



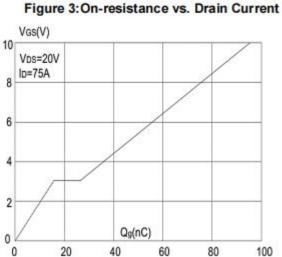


Figure 5: Gate Charge Characteristics

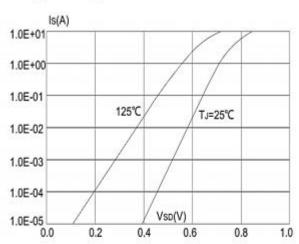


Figure 4: Body Diode Characteristics

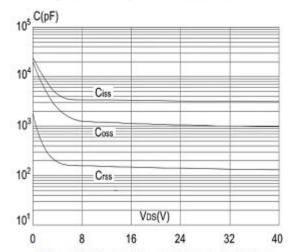
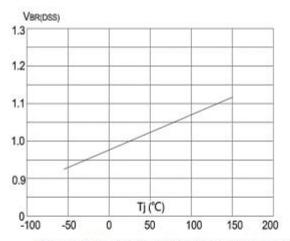


Figure 6: Capacitance Characteristics



# **Typical Characteristics (Cont.)**



Ros(on)

2.5

2.0

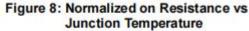
1.5

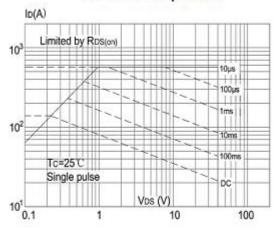
1.0

0.5

-100 -50 0 50 100 150 200

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature





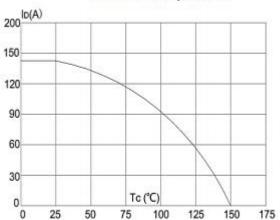
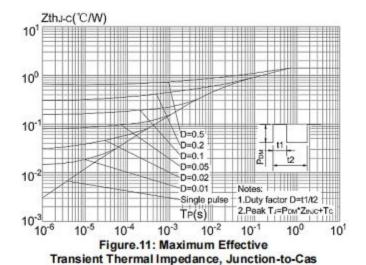


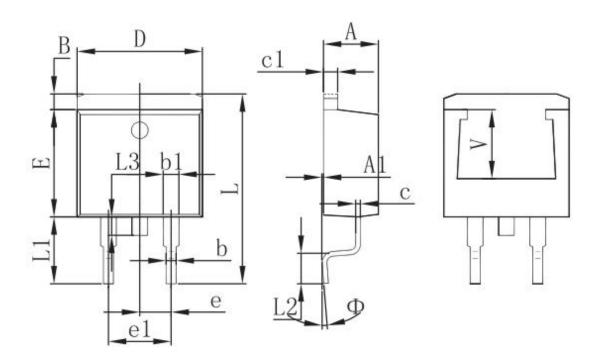
Figure 9: Maximum Safe Operating Area

Figure 10: Maximum Continuous Drain Currentvs. Case Temperature





# **Packaging information**



Combal	Dimensions In	Millimeters	Dimensions Ir	n Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
В	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
е	2.540	TYP.	0.100	TYP.
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Ф	0°	8°	0°	8°
V	5.600	REF.	0.220	REF.



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